

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09926007	NISHIBE ET AL.
	Examiner	Art Unit
	PHILIP C LEE	2152

SEARCHED

Class	Subclass	Date	Examiner
709	219,228,229,203	2/14/08	/pl/
713	190,151,153	2/14/08	/pl/
705	59	2/14/08	/pl/
709	219,228,229,203	8/14/08	/pl/
713	190,151,153	8/14/08	/pl/
705	59	8/14/08	/pl/

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with SPE:Bunjob Jaroenchonwanit regarding allowable subject matters	2/12/08	/pl/
Keywords search in EAST	2/14/08	/pl/
Inventor Named Search	2/11/08	/pl/
keywords search in 709/219,228,229,203;713/190;713/151,153,190;705/59;726/5 in EAST	2/14/08	/pl/
Google Search	2/14/08	/pl/
ACM/IEEE Search	2/14/08	/pl/
Search 709/219,228,229,203;713/190;713/151,153,190;705/59;726/5 in PG Pub	2/14/08	/pl/
update keywords search in EAST	8/14/08	/pl/
update keywords search in 709/219,228,229,203;713/151,153,190;705/59;726/5 in EAST	8/14/08	/pl/
update Google search	8/14/08	/pl/
update ACM/IEEE search	8/14/08	/pl/
Search 709/219,228,229,203;713/190;713/151,153,190;705/59;726/5 in PG Pub	8/14/08	/pl/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
709	219,228,229,203	2/14/08	/pl/
713	190,151,153	2/14/08	/pl/
705	59	2/14/08	/pl/
726	5	2/14/08	/pl/
709	219,228,229,203	8/14/08	/pl/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
713	190,151,153	8/14/08	/pl/
705	56	8/14/08	/pl/
726	5	8/14/08	/pl/